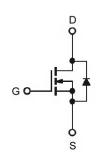


N-Channel 650-V (D-S) MOSFET

Description

The device is using advanced Super-Junction technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for AC/DC power conversion in switching mode operation for higher efficiency.

Graphic Symbol



Features

- 7A, 650V, $R_{DS(ON)typ} = 0.55\Omega@V_{GS} = 10V$
- Low Gate Charge (typical 16nC)
- High Ruggedness
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability

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Typical Applications

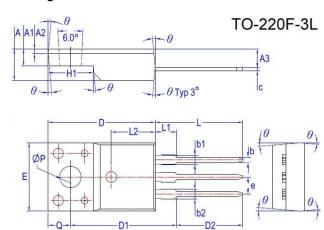
- Switching Mode Power Supply
- Adapter / Charger
- Server Power

Package type: TO-220F



RoHS Compliant

Package Dimension



REF.	Millimeter		REF.	Millimeter				
NEF.	Min.	Nom.	Max.	NEF.	Min.	Nom.	Max.	
Α	4.50	4.70	4.90	D1	15.35	-	15.95	
A1	2.34	2.54	2.74	D2	9.60	9.60 9.80		
A2		0.70REF	:	E	9.96 10.16 10.3			
A3	2.56	2.76	2.96	е	2.54BSC			
b	0.70	-	0.90	H1	6.48	6.48 6.68 6.8		
b1	1.18	-	1.43	L	12.68	12.98	13.28	
b2	-	-	1.55	L1	-	-	3.50	
С	0.40	0.50	0.65	ФР	3.06	3.18	3.28	
D	15.57	15.87	16.17	Q	3.15	-	3.45	



N-Channel 650-V (D-S) MOSFET

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings						
Symbol	Parameter	Value	Units			
V_{DS}	Drain-Source Voltage	650	V			
V _G S	Gate-Source Voltage	±30	V			
I _D	Continuous Drain Current¹ (T _C =25°C)	7.0	А			
	Continuous Drain Current¹ (Tc=100°C)	4.4	Α			
I_{DM}	Pulsed Drain Current ^{1,2}	28	Α			
las	Single Pulse Avalanche Current, L =79mH³	2.4	Α			
Eas	Single Pulse Avalanche Energy, L =79mH³	227	mJ			
dv/dt	Peak Diode Recovery dv/dt	15	V/ns			
D	Power Dissipation ⁴ (T _C =25°C)	30	W			
P_D	Derating Factor Above 25°C	0.24	W/°C			
TJ/Tstg	Operating Junction and Storage Temperature	-55 to +150	°C			

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	62.5	°C/W		
Rejc	Maximum Junction-to-Case ¹	4.17	°C/W		

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2.0	_	4.0	V
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	650	-	-	V
BV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C	-	0.68	-	V/°C
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±30V	-	-	±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =650V, V _{GS} =0V, T _C =25°C V _{DS} =520V, V _{GS} =0V, T _C =125°C	-	-	1 10	μA
R _{DS (on)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =3.5A	-	0.55	0.7	Ω
Rg	Gate Resistance	V _{GS} =V _{DS} =0V, f =1.0MHz	_	2.4	_	Ω



N-Channel 650-V (D-S) MOSFET

Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =520V		16		
Qgs	Gate-Source Charge	I _D =7A		3.6		nC
Qgd	Gate-Drain Charge	V _{GS} =10V		8.3		
td(on)	Turn-On Delay Time ²	V _{DS} =325V		10		
tr	Rise Time	I _D =7A		29		
td(off)	Turn-Off Delay Time	V _{GS} =10V		44		ns
tf	Fall Time	$R_G = 24\Omega$		26		
Ciss	Input Capacitance	V _{DS} =100V		423		
Coss	Output Capacitance	V _{GS} =0V		27		pF
Crss	Reverse Transfer Capacitance	f =1.0MHz		1.9		

Source-Drain Diode							
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
Is	Continuous Source Current ^{1,5}	V V OV 5 O	_	-	7.0		
I _{SM}	Pulsed Source Current ^{2,5}	V _G =V _D =0V, Force Current	-	-	28	A	
V _{SD}	Diode Forward Voltage ²	I _S =7A, V _{GS} =0V, T _J =25°C	_	-	1.4	V	
t _{rr}	Reverse Recovery Time ²	I _S =7A, V _{GS} =0V, dI _F / dt =		346		ns	
Qrr	Reverse Recovery Charge ²	100A/µs		2.5		μC	

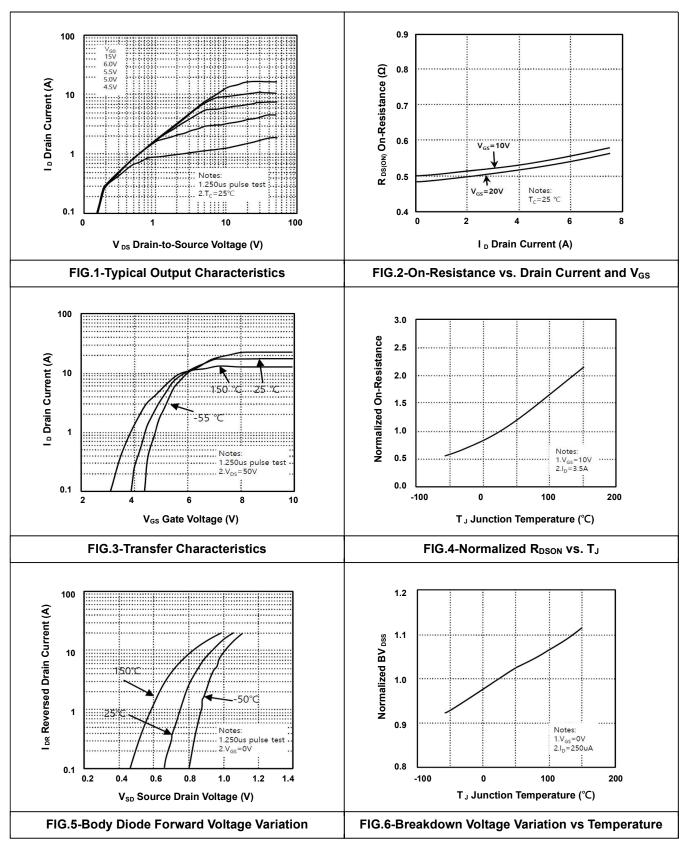
Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =100V, L=79mH, I_{AS}=2.4A.
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



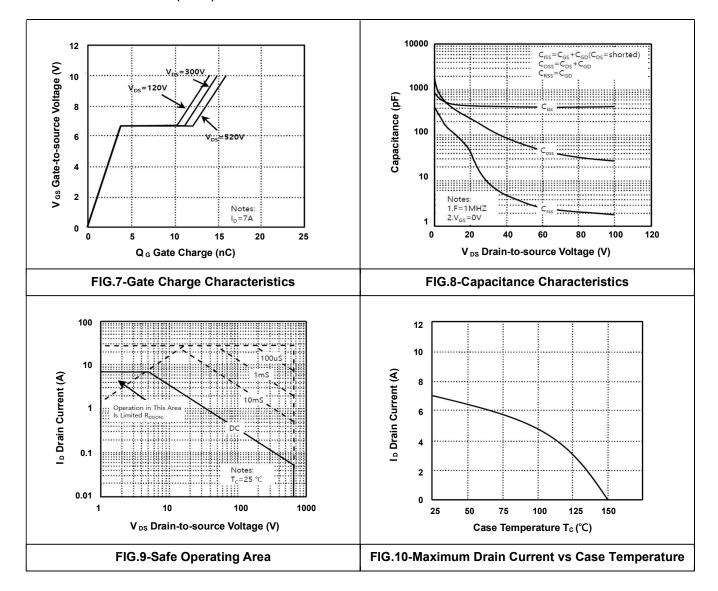
N-Channel 650-V (D-S) MOSFET

• Typical Electrical Characteristics





N-Channel 650-V (D-S) MOSFET





N-Channel 650-V (D-S) MOSFET

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